

STP10LN80K5

N-channel 800 V, 0.55 Ω typ., 8 A MDmesh™ K5 Power MOSFET in a TO-220 package

Datasheet - production data

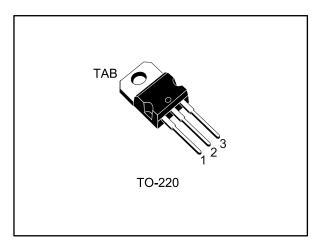
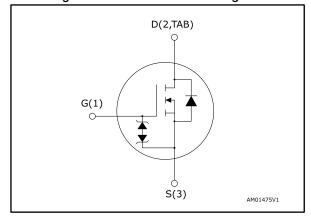


Figure 1: Internal schematic diagram



Features

Order code	V _{DS}	R _{DS(on)} max.	I _D	
STP10LN80K5	800 V	0.63 Ω	8 A	

- Industry's lowest R_{DS(on)} x area
- Industry's best figure of merit (FoM)
- Ultra-low gate charge
- 100% avalanche tested
- Zener-protected

Applications

• Switching applications

Description

This very high voltage N-channel Power MOSFET is designed using MDmesh™ K5 technology based on an innovative proprietary vertical structure. The result is a dramatic reduction in on-resistance and ultra-low gate charge for applications requiring superior power density and high efficiency.

Table 1: Device summary

Order code	Marking	Package	Packing
STP10LN80K5	10LN80K5	TO-220	Tube

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STP10LN80K5 Electrical ratings

1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit	
V _{GS}	Gate-source voltage	± 30	V	
I _D	Drain current (continuous) at T _C = 25 °C	8	Α	
I _D	Drain current (continuous) at T _C = 100 °C	5	Α	
I _{DM} ⁽¹⁾	Drain current (pulsed)	32	Α	
P _{TOT}	Total dissipation at T _C = 25 °C	110	W	
dv/dt (2)	Peak diode recovery voltage slope	4.5	1//	
dv/dt (3)	MOSFET dv/dt ruggedness	50	V/ns	
T _j	Operating junction temperature	55 to 150	°C	
T _{stg}	Storage temperature	- 55 to 150	30	

Notes:

Table 3: Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case	1.14	°C/W
R _{thj-amb}	Thermal resistance junction-ambient	62.5	°C/W

Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche current, repetitive or not repetitive (pulse width limited by T_{jmax})	2.7	Α
E _{AS}	Single pulse avalanche energy (starting T_j = 25 °C, I_D = I_{AR} , V_{DD} = 50 V)	240	mJ

 $^{^{(1)}}$ Pulse width limited by safe operating area

 $^{^{(2)}}I_{SD} \leq 8$ A, di/dt 100 A/ μ s; V $_{DS}$ peak < V $_{(BR)DSS}$, V $_{DD}$ = 640 V

 $^{^{(3)}}V_{DS} \le 640 \text{ V}$

Electrical characteristics STP10LN80K5

2 Electrical characteristics

T_C = 25 °C unless otherwise specified

Table 5: On/off-state

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	800			V
		$V_{GS} = 0 \text{ V}, V_{DS} = 800 \text{ V}$			1	μΑ
I _{DSS}	Zero gate voltage drain current	$V_{GS} = 0 \text{ V}, V_{DS} = 800 \text{ V}$ $T_{C} = 125 \text{ °C}$			50	μΑ
I _{GSS}	Gate body leakage current	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			±10	μΑ
$V_{GS(th)}$	Gate threshold voltage	$V_{DD}=V_{GS},I_D=100\;\mu A$	3	4	5	٧
R _{DS(on)}	Static drain-source on-resistance	$V_{GS} = 10 \text{ V}, I_D = 4 \text{ A}$		0.55	0.63	Ω

Table 6: Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss}	Input capacitance		-	427	-	pF
Coss	Output capacitance	$V_{DS} = 100 \text{ V}, f = 1 \text{ MHz},$ $V_{GS} = 0 \text{ V}$	-	43	-	pF
C_{rss}	Reverse transfer capacitance	VGS - 0 V	-	0.25	-	pF
C _{o(tr)} ⁽¹⁾	Equivalent capacitance time related	V _{DS} = 0 to 640 V,	-	72	-	pF
C _{o(er)} ⁽²⁾	Equivalent capacitance energy related	$V_{GS} = 0 V$		27	-	pF
R_g	Intrinsic gate resistance	$f = 1 \text{ MHz}$, $I_D = 0 \text{ A}$	-	7	-	Ω
Q_g	Total gate charge	$V_{DD} = 640 \text{ V}, I_D = 8 \text{ A}$	-	15	-	nC
Q_{gs}	Gate-source charge	V _{GS} = 10 V	-	4.2	-	nC
Q_{gd}	Gate-drain charge	See Figure 16: "Test circuit for gate charge behavior"	-	9	-	nC

Notes:

Table 7: Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time	V_{DD} = 400 V, I_{D} = 4 A, R_{G} = 4.7 Ω	1	11.8	1	ns
t _r	Rise time	$V_{GS} = 10 \text{ V}$	1	10	1	ns
t _{d(off)}	Turn-off delay time	See Figure 15: "Test circuit for resistive load switching times"	1	28	1	ns
t _f	Fall time	and Figure 20: "Switching time waveform"	-	13	-	ns



 $^{^{(1)}}$ Time related is defined as a constant equivalent capacitance giving the same charging time as Coss when V_{DS} increases from 0 to 80% V_{DSS}

 $^{^{(2)}}$ Energy related is defined as a constant equivalent capacitance giving the same stored energy as Coss when V_{DS} increases from 0 to 80% V_{DSS}

Table 8: Source-drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current		-		8	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		-		32	Α
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} = 8 A, V _{GS} = 0 V	1		1.5	V
t _{rr}	Reverse recovery time	$I_{SD} = 8 \text{ A, di/dt} = 100 \text{ A/µs, V}_{DD} =$	-	350		ns
Q _{rr}	Reverse recovery charge	60 V See Figure 17: "Test circuit for	-	3.9		μC
I _{RRM}	Reverse recovery current	inductive load switching and diode recovery times"		22.5		Α
t _{rr}	Reverse recovery time	I _{SD} = 8 A, di/dt = 100 A/μs V _{DD} =	-	505		ns
Q _{rr}	Reverse recovery charge	60 V, T _j = 150 °C See Figure 17: "Test circuit for inductive load switching and diode recovery times"	-	5		μC
I _{RRM}	Reverse recovery current		1	20		Α

Notes:

Table 9: Gate-source Zener diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
$V_{(BR)GSO}$	Gate-source breakdown voltage	$I_{GS}=\pm 1$ mA, $I_{D}=0$ A	30	-	-	V

The built-in back-to-back Zener diodes are specifically designed to enhance the ESD performance of the device. The Zener voltage facilitates efficient and cost-effective device integrity protection, thus eliminating the need for additional external componentry.

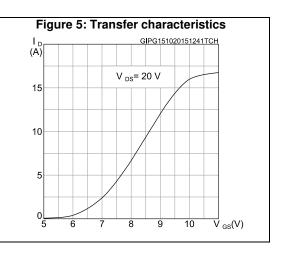
⁽¹⁾Pulse width limited by safe operating area

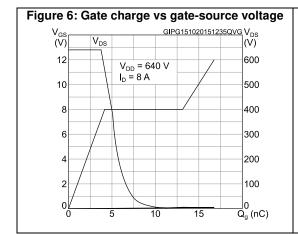
 $^{^{(2)}}$ Pulsed: pulse duration = 300 μ s, duty cycle 1.5%

2.2 Electrical characteristics (curves)

Figure 2: Safe operating area GIPG231120151312SOA (A) Operation in this area is limited by R_{DS(on)} 10 t ₀=10 μs t p=100 µs t p=1 ms 10⁰ T,≤150 °C t ₀=10 ms T_o= 25°C single pulse 10⁻¹ $\overline{V}_{DS}(V)$ 10⁻¹ 10° 10¹ 10² 10^{3}

Figure 3: Thermal impedance $\delta = 0.2$ $\delta = 0.2$ $\delta = 0.1$ $\delta = 0.1$ $\delta = 0.02$ $\delta = 0.02$ $\delta = 0.01$ SINGLE PULSE 10^{-2} 10^{-3} 10^{-1} 10^{-2} 10^{-5} 10^{-4} 10^{-3} 10^{-2} 10^{-1} $t_p(s)$





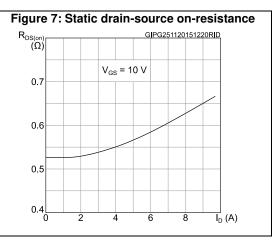


Figure 8: Capacitance variations

C (pF)

10³

10²

10¹

10⁻¹

10⁻¹

10⁰

10¹

10¹

10²

C_{ISS}

C_{RSS}

C_{RSS}

Figure 10: Normalized on-resistance vs temperature

R_{DS(on)} GIPG151020151154RON
(norm.)

2.6 V_{GS} = 10 V

2.2

1.8

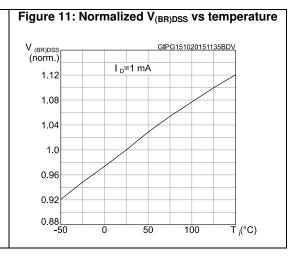
1.4

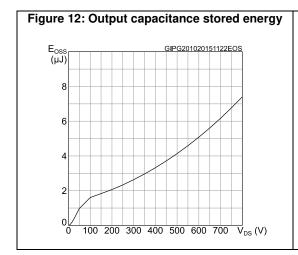
1.0

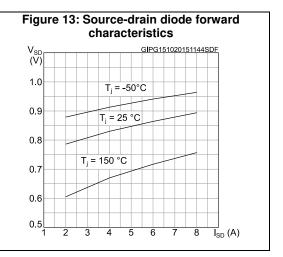
0.6

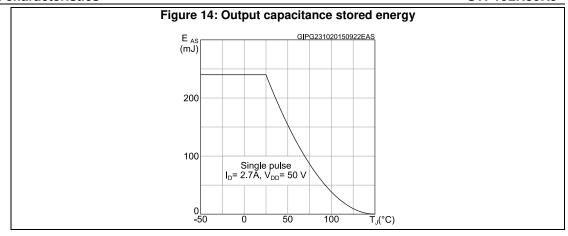
0.2

-50 0 50 100 T_j (°C)









STP10LN80K5 Test circuits

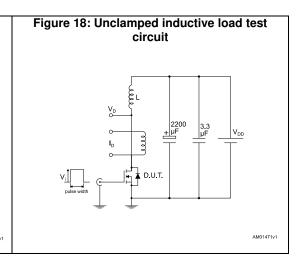
3 Test circuits

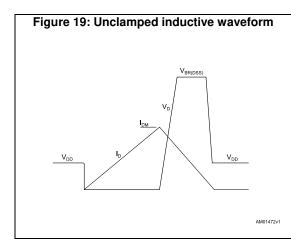
Figure 15: Test circuit for resistive load switching times

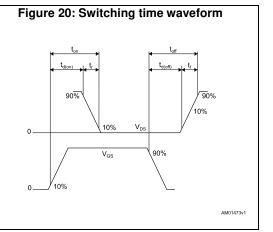
Figure 16: Test circuit for gate charge behavior

12 V 47 KΩ 100 nF 100

Figure 17: Test circuit for inductive load switching and diode recovery times







4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.

STP10LN80K5 Package information

4.1 TO-220 type A package information

Figure 21: TO-220 type A package outline

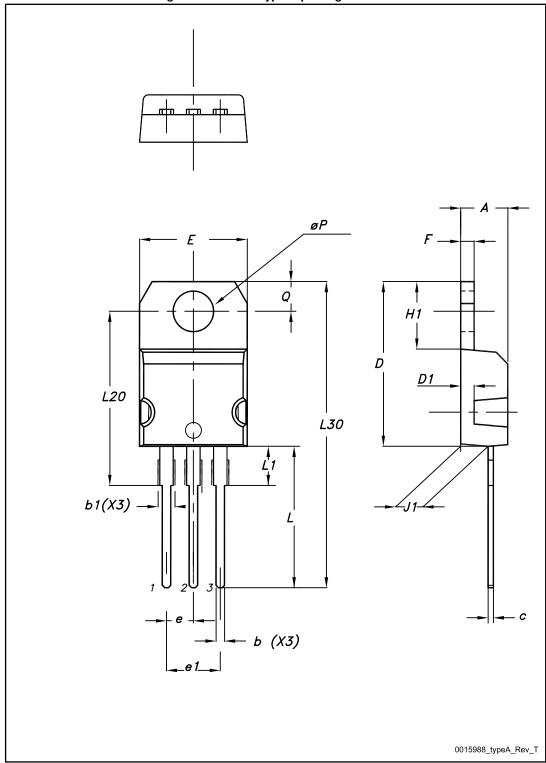


Table 10: TO-220 type A mechanical data

Dim		mm	
Dim.	Min.	Тур.	Max.
А	4.40		4.60
b	0.61		0.88
b1	1.14		1.70
С	0.48		0.70
D	15.25		15.75
D1		1.27	
E	10		10.40
е	2.40	2.40	
e1	4.95		5.15
F	1.23		1.32
H1	6.20		6.60
J1	2.40		2.72
L	13		14
L1	3.50		3.93
L20		16.40	
L30		28.90	
øΡ	3.75		3.85
Q	2.65		2.95

STP10LN80K5 Revision history

5 Revision history

Table 11: Document revision history

Date	Revision	Changes
10-Jun-2015	1	First release.
14-Dec-2015	2	Datasheet promoted from preliminary data to production data Modified: Table 2: "Absolute maximum ratings", Table 3: "Thermal data", Table 4: "Avalanche characteristics", Table 5: "On/off-state", Table 6: "Dynamic", Figure 2: "Safe operating area", Figure 3: "Thermal impedance", Figure 4: "Output characteristics" and Figure 7: "Static drain-source on-resistance" Minor text changes

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